Exchange-Coupling-Induced Symmetry Breaking in Topological Insulators

Peng Wei, ^{1,*} Ferhat Katmis, ^{1,2} Badih A. Assaf, ³ Hadar Steinberg, ² Pablo Jarillo-Herrero, ² Donald Heiman, ³ and Jagadeesh S. Moodera ^{1,2,†}

¹Francis Bitter Magnet Lab, Massachusetts Institute of Technology, Cambridge, Massachusetts 02139, USA

²Department of Physics, Massachusetts Institute of Technology, Cambridge, Massachusetts 02139, USA

³Department of Physics, Northeastern University, Boston, Massachusetts 02115, USA

(Received 20 December 2012; published 30 April 2013)

An exchange gap in the Dirac surface states of a topological insulator (TI) is necessary for observing the predicted unique features such as the topological magnetoelectric effect as well as to confine Majorana fermions. We experimentally demonstrate proximity-induced ferromagnetism in a TI, combining a ferromagnetic insulator EuS layer with Bi_2Se_3 , without introducing defects. By magnetic and magnetotransport studies, including anomalous Hall effect and magnetoresistance measurements, we show the emergence of a ferromagnetic phase in TI, a step forward in unveiling their exotic properties.

DOI: 10.1103/PhysRevLett.110.186807 PACS numbers: 73.20.-r, 71.70.Gm, 73.40.-c, 75.50.Pp

Three-dimensional topological insulators (TIs) are materials carrying surface states protected by time-reversal symmetry [1,2]. The short-range nature of magnetic proximity coupling with a ferromagnetic insulator (FI) allows the TI surface states to experience the ferromagnetic interactions, where the symmetry breaking happens right at the interface [3–6], rather than affecting the majority bulk states or introducing defects. The well-behaved Heisenberg FI, such as EuS, is an excellent candidate to isolate the magnetic response of the surface states from the parallel conduction of the TI bulk material. Furthermore, the local time-reversal symmetry breaking is essential for inducing a quantized topological magnetoelectric response [7]. This may be used to investigate interesting emergent phenomena, such as the zero-field half-integer quantum Hall effect [7], the topological magnetoelectric effect [7,8], and the magnetic monopole [9] to name a few.

Experimentally the most common method of introducing ferromagnetic order in TI is by doping with specific elements; in this case, it is hard to separate the surface and the bulk phases [10-14]. Although a surface ferromagnetic order is shown achievable by uniformly depositing magnetic atoms, i.e. Fe, over the TI surface [15,16], the transport properties of a TI can be influenced by the metallic ferromagnetic overlayer or atoms. Besides, the doping of magnetic elements inevitably introduces crystal defects, magnetic scattering centers, as well as impurity states in the insulating gap, which are detrimental to mobility and the transport of spin-momentum locked surface electrons in TIs [1]. From the point of view of confining Majorana fermions in topological superconductors [17,18], the exchange field of a FI is capable of lifting the spin degeneracy without destroying the superconductivity pairing [5,6]. This is in contrast to the adverse effects resulting from the introduction of magnetic impurities. In combination with a FI, the Majorana bound states can be well established on the top surface of a superconducting TI [19] or superconducting proximity-coupled TI [20].

Here, we introduce ferromagnetic order onto the surface of Bi₂Se₃ thin films by using the FI EuS [Fig. 1(a)] forming Bi₂Se₃/EuS heterostructures. Ultrathin FI EuS layers are stable with good growth characteristics and a clean interface on a variety of materials; they form excellent tunnel barriers even down to 1 nm thickness showing near ideal

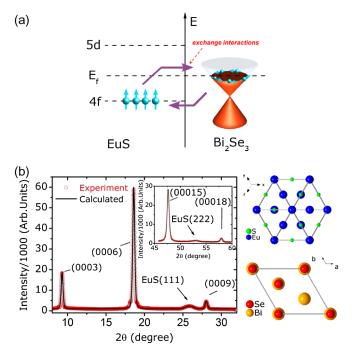


FIG. 1 (color online). (a) The diagram illustrates the ferromagnetic exchange interaction between Bi₂Se₃ and EuS. (b) The measured (open circle) and calculated (solid line) out-of-plane x-ray diffraction scan for a high-quality epitaxial Bi₂Se₃[0001]// EuS[111] bilayer. The inset shows the data at larger angles. The two cartoon images show the lattice structures of EuS along the 111 direction and Bi₂Se₃ along the 0001 direction.

area coverage [5,6,21,22]. Although the magnetic proximity effect of EuS on a superconductor has been clearly demonstrated [5], its effectiveness on the TI Dirac surface state is an open question. This exchange phenomenon can be expected to have a profound influence on the novel surface Dirac electron system, especially the spin-momentum locked helical electronic states in TIs [1,23,24]. Achieving this is nontrivial as it critically depends on the control of the TI/EuS heterostructures interface down to the last atomic layer to be able to transmit the exchange interaction across the interface. This also depends on the growth condition of EuS on bismuth compounds.

The bilayer structure growth was carried out in a molecular beam epitaxy apparatus in an ultrahigh vacuum environment (low 10⁻¹⁰ torr). Thin film Bi₂Se₃ were epitaxially grown on Si(111) or Al₂O₃(0001) substrates by coevaporating high-purity Bi and Se constituents from separate conventional Knudsen cells at 450 K. EuS was grown in situ on Bi₂Se₃ from a single e-beam source at room temperature, followed by a capping layer of 4 nm amorphous Al₂O₃. The quality of the layers were confirmed by high-resolution x-ray diffraction, using 1.54 Å Cu- $K_{\alpha 1}$ radiation, which was also used to confirm the thickness and smoothness of the grown layers. Figure 1(b) shows the x-ray diffraction characterizations revealing the single phase of hexagonal Bi₂Se₃ and cubic EuS indicating the epitaxial growth without any clustering. The growth relations on sapphire and silicon substrates are Al₂O₃[0001]// $Bi_2Se_3[0001]//EuS[111]$ and $Si[111]//Bi_2Se_3[0001]//$ EuS[111]. Low angle x-ray reflectivity studies confirmed a sharp Bi₂Se₃/EuS interface.

Several samples were grown simultaneously with a shadow mask technique. The Bi₂Se₃ layer thickness was fixed at 20 nm, while the EuS film thickness was varied locally (1, 3, 5, 7, and 10 nm in different lateral sections of the same Bi₂Se₃ film). Further, a sample of 1 nm EuS on Si(111) was also grown in situ forming a set of TI/FI bilayer samples and a single layer control sample for the studies. For transport measurements, control samples of Bi₂Se₃ thin films capped with Al₂O₃ were grown simultaneously. While the control samples did not display magnetic behavior, they showed typical weak antilocalization (WAL) effect under a perpendicular magnetic field (only a weak field dependence, and no WAL, for in-plane magnetic field) and with no hysteresis, as seen by others [25,26] as well as our previous observations [27]. The samples were patterned into standard Hall bar devices with a channel width of 60 μ m and channel length of 400 μ m. The charge carriers of the Bi_2Se_3 layers were determined to be n type with a density $(n_{3D}) \sim 4 \times 10^{19}$ cm⁻³ at 4.2 K, which was not sensitive to the EuS capping. For several samples (both control and bilayer samples), temperature dependence of $n_{\rm 3D}$ was monitored. We found only a small decrease (<1%) in n_{3D} as the temperature went below ~40 K, with the most decrease occurring below ~ 10 K in both bilayer and control samples. No significant change was observed for $n_{\rm 3D}$ across $T_{\rm C}$ in bilayer samples due to the development of interface ferromagnetism. The large background contribution from the bulk conductivity could have precluded observing any changes across $T_{\rm C}$.

The magnetic properties of the $\mathrm{Bi}_2\mathrm{Se}_3/\mathrm{EuS}$ heterostructures were determined by magnetization measurements, performed in a Quantum Design Magnetic Property Measurement System. All TI/FI bilayer samples exhibit ferromagnetic phase transitions when the temperature decreases below about 20 K [Fig. 2(a) inset]. Also shown here is the magnetic hysteresis loop with a sizeable remnant magnetization and coercive field H_{C} indicating an in-plane easy axis. The T_{C} was estimated from the point at which the slope of M vs T data sharply increased. It may be noted that the T_{C} is influenced by the applied field during cooling (unless this field is very small) as well as due to high carrier density. These factors can raise T_{C} above the bulk T_{C} of EuS [28].

In the following we demonstrate that EuS induces a significant magnetic moment on the surface of the Bi_2Se_3 film. Figure 2(a) shows the measured magnetic moment of

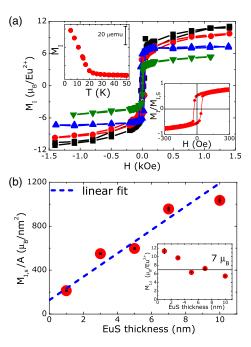


FIG. 2 (color online). (a) Magnetic moment per $\mathrm{Eu^{2+}}$ ion as a function of magnetic field of $\mathrm{Bi_2Se_3/EuS}$ bilayer samples for three thicknesses of EuS: 1 nm (black squares), 3 nm (red circles), and 7 nm (blue up triangles), measured at 4.8 K. The magnetic field was applied in the film plane. The control sample data for 1 nm EuS on Si(111) are shown in green down triangles. The inset shows the temperature dependence of the magnetic moment, and the low-field hysteresis for the $\mathrm{Bi_2Se_3/EuS}$ (3 nm) sample. (b) Saturation magnetic moment per unit area (see text) as a function of the thickness of the EuS layers, where the nonzero intercept is the induced interfacial magnetic moment. The size of the data points includes the error in M and film thickness. The inset shows the saturation magnetic moment (at 1.5 kOe) per Eu^{2+} ion as a function of EuS thickness.

three bilayer samples having varying thicknesses and a control sample of Si(111)/EuS. It is striking that for all Bi₂Se₃/EuS samples, each Eu²⁺ ion contributes a saturation magnetic moment $M_{\rm LS}$ that is higher than the $7\mu_{\rm B}$ upper limit of EuS [6]. Moreover, $M_{\rm LS}$ increases as the thickness of the EuS layer decreases [inset of Fig. 2(b)]. It reaches a maximum of $11.3\mu_B/Eu^{2+}$ in the bilayer sample with 1 nm EuS, which is 60% larger than the $7\mu_{\rm B}/{\rm Eu}^{2+}$ value [6]. It may be noted that the maximum number of deposited EuS molecules was monitored by the quartz sensor. Since the excess moment cannot be accounted for by the EuS layer alone, its origin is attributed to the induced moment at the Bi₂Se₃/EuS interface. On the other hand, the control sample shows an $M_{\rm LS}$ of $5.9\mu_{\rm B}/{\rm Eu}^{2+}$ [Fig. 2(a)], indicating that the enhanced moment seen in the Bi₂Se₃/ EuS bilayer is not due to the EuS layer or the film thicknessrelated properties. Furthermore, EuS shows more favorable growth on Bi_2Se_3 compared to Si(111). The H_C of 1 nm EuS on Bi₂Se₃ (\sim 18 Oe) is 3 times larger than the $H_{\rm C}$ of 1 nm EuS on Si(111), which is only 6 Oe.

The magnitude of the induced magnetization can be extracted through the following analysis. The total saturation moment is expressed as $M_{\rm S}=2J_z\mu_{\rm B}\rho_{\rm N}dA+m_0A$. Here, the theoretical maximum is $J_z=7/2$ for each Eu²⁺ ion in EuS [6], d is the thickness of the EuS film, A the area of the sample, and ρ_N the number density of Eu²⁺ ions. The induced magnetic moment at the interface is represented by m_0 . A plot of M_S/A vs d for five bilayer samples [Fig. 2(b)] shows linear dependence. A linear fit yields $2J_z\mu_{\rm B}=5.7\pm0.9~\mu_{\rm B}/{\rm Eu}^{2+}$ and $m_0=(1.3\pm0.5)\times10^2~\mu_{\rm B}/{\rm nm}^2$. This value for $2J_z\mu_{\rm B}$ is in good agreement with the control sample of Si(111)/EuS, as well as previously reported values [22,29]. The nonzero intercept represents an induced moment in Bi₂Se₃ at the interface: a maximum estimated value $\sim 20 \mu_B/\text{nm}^2$ based on $n_{\rm 3D}$ and Landé g factor $g \sim 50$ of Bi₂Se₃ [30]. This extra moment can be expected to come from the magnetized interfacial atoms as well as that due to the polarization of the electron gas in Bi₂Se₃ (see the Supplemental Material [31]). Possible spin polarized electronic states originating from the hybridizations between EuS and Bi₂Se₃ can be respected (see Ref. [3] and the Supplemental Material [31]). In particular, it could be assisted by the large Landé g factor of surface electrons [30]. Although an extensive interfacial characterization study for a detailed understanding of the coupling mechanism leading to the induced interface magnetic moment would be necessary in the future, the electrical transport and magnetic data shown here self-consistently support the interpretation. Growth related artifacts such as clustering of EuS or Eu atoms is ruled out (cross-sectional TEM studies proves this) as it cannot provide an increase of the magnetic moment. It may be noted that we can form excellent tunnel barriers even down to 0.8 nm of EuS showing standard tunneling characteristics including Josephson tunneling in other systems [6].

The above magnetization studies indicate that the interface region of Bi₂Se₃ becomes magnetized. Thus, it creates

broken time-reversal symmetry and should translate into magnetic signatures in electrical transport. To confirm this, the magnetoresistance (MR) $\Delta \rho / \rho_{\rm H=0}$ of bilayers was studied using standard Hall bar samples with in-plane magnetic fields. Figure 3(a) shows such a measurement for a Bi₂Se₃/EuS (1 nm EuS) sample, where an unusual feature consisting of sharp v-shaped dips in the resistance can be seen at 1 K, and duplicated in several other samples. These dips are hysteretic, that is, they appear once for a given direction of the field sweep. The temperature dependence of the magnitude of the MR dip is shown in Fig. 3(b), decreasing as temperature increases. Also plotted here is the field value where the dip occurs, H_{\min} , which shows a similar decrease with increasing temperature. The values of H_{\min} are consistent with the $H_{\rm C}$ values, namely, H_{\min} approaches $H_{\rm C} \sim 18$ Oe at 4.8 K. These observations point to the ferromagnetic origin of the effect. While the Curie temperature $T_{\rm C}$ of the bilayer sample is large (~20 K), the hysteretic MR is only visible below around 4 K. Furthermore, the temperature dependence suggests that the hysteretic MR does not arise from charges trapped in EuS, since their conductance contribution would be activated at elevated temperatures, and thus would instead show increasing MR for increasing temperature.

The origin of this hysteretic MR appears to be unconventional, as the resistance always goes through a minimum at

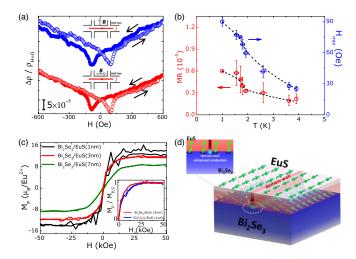


FIG. 3 (color online). (a) Planar magnetoresistivity as a function of applied in-plane magnetic field of a $\rm Bi_2Se_3/EuS$ (1 nm) sample at T=1.0 K showing hysteretic minima at the coercive field positions. Curves are shifted for clarity. The inset shows the corresponding field and current directions in the Hall bar. (b) MR ratio (magnitude of MR dip) and the coercive field $H_{\rm C}$ as a function of temperature. (c) Perpendicular magnetic moment per $\rm Eu^{2+}$ ion, $M_{\rm P}$, at large fields showing higher value of the saturation moment for thicker EuS layer. Inset shows the faster saturation of $M_{\rm P}$ for the $\rm Bi_2Se_3/EuS$ (3 nm) sample compared to 1 nm EuS grown on Si(111). (d) Schematic diagram showing the inferred magnetic moment distribution in magnetic domains of $\rm Bi_2Se_3/EuS$ interface. A perpendicular domain wall (denoted in light blue) may form at the interface that enhances the overall sample conduction.

 $H_{\rm C}$. This minimum coincides with the zero net magnetization of the ferromagnetic system where random magnetic domains develop. These random domains are expected to have an isotropic arrangement, consistent with the observed isotropic in-plane MR shown in Fig. 3(a), which is dramatically different from the anisotropic magnetoresistance commonly seen in ferromagnetic materials [32–34]. Moreover, the enhancement of the conductance of Bi₂Se₃ coinciding with the domain structures at $H_{\rm C}$ is seen in all Bi₂Se₃/EuS samples. By applying a perpendicular magnetic field, Fig. 3(c) demonstrates that the saturation moment $M_{P,S}$ is even larger compared to M_{LS} in Fig. 2(a). Furthermore, M_P shows a steeper rise with an increasing field in the Bi₂Se₃/EuS (3 nm) sample compared to the 1 nm EuS grown on Si(111) [Fig. 3(c) inset], even though thicker EuS thin films favor inplane anisotropy [Fig. 3(c)]. This proves that the perpendicular anisotropy is preferred for EuS films grown on Bi₂Se₃, which is attributed to the strong spin-orbit coupling of Bi₂Se₃ [35,36], as well as likely related to the large anisotropy of the g factor for the interface electrons seen in bulk Bi₂Se₃ [37], and which may result in a canting of the magnetic moment right at the Bi_2Se_3/EuS interface [Fig. 3(d)]. At H_C , domain walls can form in the interface magnetic layer by the formation of randomly oriented magnetic domains [Fig. 3(d)]. The topological surface states at the domain wall would have low mass. The chiral conduction modes are predicted to propagate along the domain wall similar to the quantum Hall edge channels [1,2]. This could enhance the overall conduction in the sample compared to the condition with no domain walls, leading to the resistance dips shown in Fig. 3(a). A similar effect is seen in impurity-doped Bi₂Te₃ by tuning the Fermi level across its surface Dirac point [13]. However, in the present work this unique property of ferromagnetic TI in heterostructured thin film bilayers is observed even without the electrostatic gating, which could be advantageous for applications. As a result of the induced canted magnetization at the interface, the hysteretic MR(T) could differ from the M(T) of the overall EuS film. Both ferromagnetism of EuS and the coupling between EuS and Bi₂Se₃ have to be strong to signify this effect. On the other hand, a smaller $T_{\rm C}$ of the induced interfacial ferromagnetic layer than that of an EuS film can be expected due to possible quantum fluctuations [38], and weakening of the canted interfacial spins, coupled to adjacent in-plane parallel spins, while an increasing temperature may explain the lower onset temperature for the hysteretic MR. Further control of interface quality can be expected to result in higher remnant perpendicular magnetization.

Hall effect data of the control sample (with perpendicular magnetic fields up to 4 T) showed linear magnetic field dependence [Fig. 4(a) inset], which does not change significantly with temperature. For bilayer samples [Figs. 4(a) and 4(b)], the behavior is clearly different, with features exhibiting their ferromagnetic nature. A further consequence of the ferromagnetic conducting interface is the appearance of the anomalous Hall effect (AHE) [39].

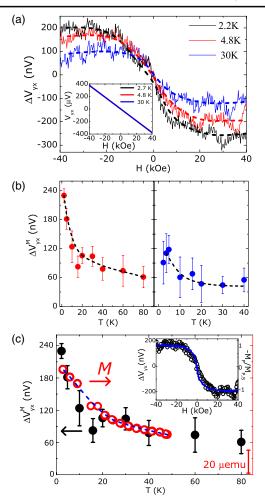


FIG. 4 (color online). (a) Nonlinear contribution to the Hall voltage, $\Delta V_{\rm yx}(H)$, as a function of applied perpendicular magnetic field at three temperatures showing smaller value of the saturation Hall voltage at higher temperature. Inset shows Hall voltage $V_{\rm yx}(H)$ of the control sample ${\rm Bi}_2{\rm Se}_3$. (b) Saturated nonlinear Hall voltage, $\Delta V_{\rm yx}{}^{\rm M}$, as a function of temperature for ${\rm Bi}_2{\rm Se}_3/{\rm EuS}$ (1 nm) (right) and ${\rm Bi}_2{\rm Se}_3/{\rm EuS}$ (3 nm) (left). (c) Comparison of $\Delta V_{\rm yx}{}^{\rm M}(T)$ (black solid dots) to the magnetization M(T) (red open circles) for the ${\rm Bi}_2{\rm Se}_3/{\rm EuS}$ (3 nm) sample. The inset compares $V_{\rm yx}(H)$ (open circles) to M(H) (solid line), illustrating the saturation occurring at high perpendicular fields.

Figure 4(a) shows the nonlinear contribution to the Hall voltage, $\Delta V_{\rm yx}(H)$, which is extracted by removing the dominant linear contribution. The magnitude of the saturation voltage, $\Delta V_{\rm yx}{}^{\rm M}$, versus temperature is shown in Fig. 4(b). Here, $\Delta V_{\rm yx}{}^{\rm M}(T)$ is seen to increase steeply below T_C . The temperature at the onset of the steep rise is higher for the Bi₂Se₃/EuS (3 nm) sample than for the Bi₂Se₃/EuS (1 nm) sample, commensurate with the higher T_C for thicker EuS films [40]. In addition, $\Delta V_{\rm yx}{}^{\rm M}(T)$ and M(T) have similar temperature dependence [Fig. 4(c)], and $V_{\rm yx}{}^{\rm M}(H)$ and M(H) have similar field dependence [Fig. 4(c) inset], clearly pointing to the ferromagnetic origin of $\Delta V_{\rm yx}(H)$. On the other hand, the control sample of Bi₂Se₃ capped with Al₂O₃ did

not show this sharp rise below ~ 15 K in the nonlinear Hall signal. The existence of the anomalous Hall effect further confirms the induced ferromagnetic order in Bi_2Se_3 . Finally, the dominance of the ordinary Hall voltage over the much smaller AHE voltage might be due to the parallel bulk conducting channel of the 20 nm Bi_2Se_3 that shorts the AHE signal [13]. By reducing the bulk carrier density one could expect a well-defined AHE, as well as a larger hysteretic MR in TI/FI heterostructures.

In summary, Bi₂Se₃/EuS heterostructures exhibit proximity-induced interfacial magnetization. This effect originates from a uniform exchange field over the TI surface, without structurally disturbing the TI. This local symmetry breaking technique not only enables the creation of cleaner ferromagnetic TI systems with larger surface exchange gaps, superior to the approach with magnetic impurity doping [41] but also allows a greater freedom in nanopatterning lateral TI heterostructures, where designated regions with broken time-reversal symmetry can be created. Similar heterostructures have the potential of developing a variety of technologically advanced devices based on the predicted novel electrical excitations in TI. For example, devices holding zero-field quantum Hall edge channels could be fabricated using TI films sandwiched by FI, as well as systems holding Majorana bound states through the patterning of FI on superconducting TI surfaces.

The authors acknowledge the valuable discussion and assistance of P. A. Lee, L. Fu, J. Shi, S.-Q. Shen, G.-X. Miao, and H.-Z. Lu. We would like to thank the MIT MRSEC for support through the MRSEC Program of the NSF under Grant No. DMR-0819762. Part of this work was carried out at the CMSE shared experimental facilities. P. W. and J. S. M. thank the NSF for support from DMR Grant No. 1207469, and thank the ONR for support under Grants No. N00014-09-1-0177 and N00014-13-1-0301. B. A. A. and D. H. thank the NSF for support from DMR Grant No. 0907007.

- *pwei@mit.edu
 †moodera@mit.edu
- [1] X.-L. Qi and S.-C. Zhang, Rev. Mod. Phys. **83**, 1057 (2011).
- [2] M. Z. Hasan and C. L. Kane, Rev. Mod. Phys. **82**, 3045 (2010).
- [3] P.G. De Gennes, Phys. Lett. 23, 10 (1966).
- [4] G. Sarma, J. Phys. Chem. Solids 24, 1029 (1963).
- [5] X. Hao, J. S. Moodera, and R. Meservey, Phys. Rev. Lett. 67, 1342 (1991).
- [6] J. S. Moodera, T. S. Santos, and T. Nagahama, J. Phys. Condens. Matter 19, 165202 (2007).
- [7] X. L. Qi, T. L. Hughes, and S. C. Zhang, Phys. Rev. B 78, 195424 (2008).
- [8] A. M. Essin, J. E. Moore, and D. Vanderbilt, Phys. Rev. Lett. **102**, 146805 (2009).

- [9] X. L. Qi, R. D. Li, J. D. Zang, and S. C. Zhang, Science 323, 1184 (2009).
- [10] Y. L. Chen et al., Science 329, 659 (2010).
- [11] L. A. Wray, S.-Y. Xu, Y. Xia, D. Hsieh, A. V. Fedorov, Y. S. Hor, R. J. Cava, A. Bansil, H. Lin, and M. Z. Hasan, Nat. Phys. 7, 32 (2010).
- [12] P. P. J. Haazen, J.-B. Laloe, T. J. Nummy, H. J. M. Swagten, P. Jarillo-Herrero, D. Heiman, and J. S. Moodera, Appl. Phys. Lett. 100, 082404 (2012).
- [13] J. G. Checkelsky, J. Ye, Y. Onose, Y. Iwasa, and Y. Tokura, Nat. Phys. 8, 729 (2012).
- [14] S.-Y. Xu et al., Nat. Phys. 8, 616 (2012).
- [15] Q. Liu, C.-X. Liu, C. Xu, X.-L. Qi, and S.-C. Zhang, Phys. Rev. Lett. **102**, 156603 (2009).
- [16] I. Vobornik, U. Manju, J. Fujii, F. Borgatti, P. Torelli, D. Krizmancic, Y. S. Hor, R. J. Cava, and G. Panaccione, Nano Lett. 11, 4079 (2011).
- [17] L. Fu and C. L. Kane, Phys. Rev. Lett. 100, 096407 (2008).
- [18] A. C. Potter and P. A. Lee, Phys. Rev. B 83, 094525 (2011).
- [19] Y. S. Hor, A. J. Williams, J. G. Checkelsky, P. Roushan, J. Seo, Q. Xu, H. W. Zandbergen, A. Yazdani, N. P. Ong, and R. J. Cava, Phys. Rev. Lett. 104, 057001 (2010).
- [20] M.-X. Wang et al., Science 336, 52 (2012).
- [21] G.-X. Miao, M. Müller, and J.S. Moodera, Phys. Rev. Lett. 102, 076601 (2009).
- [22] G. Miao, Appl. Phys. Lett. 94, 182504 (2009).
- [23] I. Garate and M. Franz, Phys. Rev. Lett. 104, 146802 (2010).
- [24] T. Yokoyama, Y. Tanaka, and N. Nagaosa, Phys. Rev. B 81, 121401 (2010).
- [25] J. Chen et al., Phys. Rev. Lett. 105, 176602 (2010).
- [26] X. Wang, X. He, T. Guan, J. Liao, C. Lin, K. Wu, Y. Li, and C. Zeng, Physica (Amsterdam) **46**, 236 (2012).
- [27] H. Steinberg, J. B. Laloë, V. Fatemi, J. S. Moodera, and P. Jarillo-Herrero, Phys. Rev. B 84, 233101 (2011).
- [28] A. Mauger and C. Godart, Phys. Rep. 141, 51 (1986).
- [29] M. Muller, R. Schreiber, and C. M. Schneider, J. Appl. Phys. 109, 07C710, (2011).
- [30] J. G. Analytis, R. D. McDonald, S. C. Riggs, J.-H. Chu, G. S. Boebinger, and I. R. Fisher, Nat. Phys. 6, 960 (2010).
- [31] See Supplemental Material at http://link.aps.org/supplemental/10.1103/PhysRevLett.110.186807 for the preliminary x-ray magnetic circular dichroism result on the Bi₂Se₃/EuS sample.
- [32] T. McGuire and R. Potter, IEEE Trans. Magn. 11, 1018 (1975).
- [33] C. Gould, C. Rüster, T. Jungwirth, E. Girgis, G. M. Schott, R. Giraud, K. Brunner, G. Schmidt, and L. W. Molenkamp, Phys. Rev. Lett. 93, 117203 (2004).
- [34] S. Y. Huang, X. Fan, D. Qu, Y.P. Chen, W.G. Wang, J. Wu, T. Y. Chen, J. Q. Xiao, and C. L. Chien, Phys. Rev. Lett. 109, 107204 (2012).
- [35] C. Chappert and P. Bruno, J. Appl. Phys. **64**, 5736 (1988).
- [36] L. Néel, J. Phys. Radium 15, 225 (1954).
- [37] H. Köhler and E. Wöchner, Phys. Status Solidi B **67**, 665 (1975).
- [38] F. S. Nogueira and I. Eremin, Phys. Rev. Lett. **109**, 237203 (2012).
- [39] N. Nagaosa, J. Sinova, S. Onoda, A. H. MacDonald, and N. P. Ong, Rev. Mod. Phys. 82, 1539 (2010).
- [40] R. Schiller and W. Nolting, Solid State Commun. 110, 121 (1999).
- [41] W. Luo and X. L. Qi, Phys. Rev. B 87, 085431 (2013).